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High frequency spin dynamics in hybrid metallic devices

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Chapter 8

Microwave spectroscopy on magnetization reversal dynamics of nanomagnets with electronic detection

In this chapter, we demonstrate a detection method for microwave spectroscopy on magnetization reversal dynamics of nanomagnets. Measurement of the nanomagnet anisotropic magnetoresistance was used for probing how magnetization reversal is resonantly enhanced by microwave magnetic fields. We used Co strips of $2\ \mu\text{m} \times 130\ \text{nm} \times 40\ \text{nm}$, and microwave fields were applied via an on-chip coplanar wave guide. The method was applied for demonstrating single domain-wall resonance, and studying the role of resonant domain-wall dynamics in magnetization reversal.

8.1 Introduction

It is crucial for the implementation and miniaturization of magnetic and spintronic devices to understand the magnetization dynamics of nanostructures at GHz frequencies. Our goal is to create and detect large amplitude ferromagnetic resonance [1] (FMR) of individual nanomagnets. This is of interest for realizing fast magnetization reversal, and for driving spin currents into adjacent normal metals [2]. Cavity-based microwave techniques have been used for studying FMR, but these are not sensitive enough for studies of individual nanomagnets and the dynamics of individual domain walls. Gui *et al.* [3], however, recently showed with a ferromagnetic grating that DC transport measurements on the ferromagnet can form a very sensitive probe for microwave induced FMR, charge dissipation, and their

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interplay. Earlier experiments already showed that transport measurements also allow for probing the magnetic configuration of individual submicron structures. Ono *et al.* [4] using the giant magnetoresistance (GMR) effect, and Klaui *et al.* [5] using the anisotropic magnetoresistance (AMR) effect, have detected domain wall motion in magnetic nanowires. Work on current-induced dynamics of a single domain wall in a magnetic nanowire by Saitoh *et al.* [6] allowed for determining the domain wall mass. Further, the GMR effect was used for real-time detection of the dynamics of spin valve devices [7, 8] and for observing spin-transfer induced magnetic oscillations at GHz frequencies [9]. We demonstrate here how the AMR effect can be used for detecting how microwave magnetic fields resonantly enhance magnetization reversal of individual nanomagnets that are embedded in electronic nanodevices. This allows for analyzing the magnetization dynamics in the metastable state prior to reversal of the magnetization.

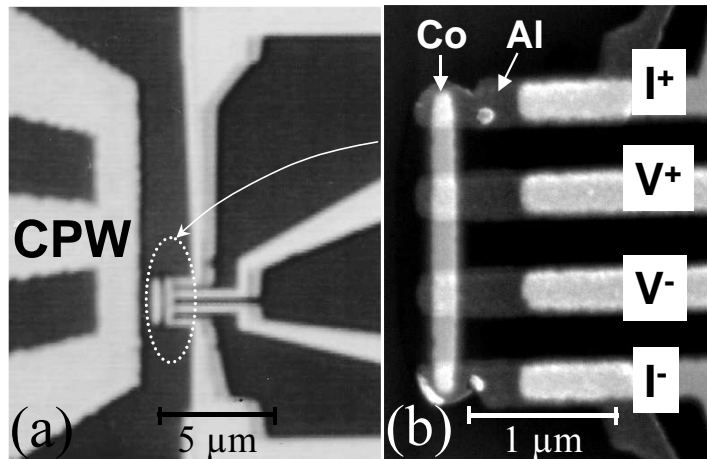


Figure 8.1: (a) Optical microscope picture of the device including the CPW with a short at the end. (b) Scanning Electron Microscope picture of the Co strip, contacted by four Al fingers.

8.2 Experimental realization

We use devices that are patterned by electron beam lithography. In a first step, a gold coplanar waveguide (CPW) is defined with standard lift-off techniques (Fig. 8.1 (a)). The short at the end of the CPW forms a 2 μm wide microwave line, and provides the microwave magnetic field. Then a device containing the nanomagnet is fabricated close to the microwave line with shadow mask techniques [10]. In this chapter we concentrate on the case of a cobalt strip of 2 μm × 130 nm × 40 nm. It is deposited by e-beam evaporation parallel to the microwave line at 2 μm distance. In the same

vacuum cycle, four aluminum fingers are deposited that form clean contacts with the Co strip (Fig. 8.1 (b)). The microwave field is perpendicular to the plane of the sample and the equilibrium direction of the magnetization, which is a condition for driving the FMR [11]. The CPW is connected to a microwave signal generator via microwave probes with 40 GHz bandwidth.

Our detection method of FMR is based on microwave-assisted magnetization reversal [12, 13]. Slowly sweeping a static magnetic field parallel to the strip's long dimension is used for inducing a sudden switch event between the two saturated magnetic configurations. When microwave-driven FMR occurs, the magnetic configuration is excited out of a metastable state, and the static-field induced switching occurs at values closer to zero field. The switching fields are deduced from recording the strip's resistance $R(H)$ during the field sweep. When approaching the switching field, the magnetization is pushed slightly out of its zero-field configuration, which causes a reduction of the strip's AMR (the strip's AMR ratio is about 0.6%). Magnetization reversal is identified from a sudden return to the zero-field AMR value (Fig. 8.2). The resistance of the sample is measured in a four probe geometry (see Fig. 8.1) with a lock-in detection technique and 5 μA ac bias current. All measurements are done at room temperature.

8.3 Results and discussion

The switching of the samples is first characterized without applying a microwave field. In our particular sample, two types of $R(H)$ curves can be obtained (Fig. 8.2). This can be understood when considering that in high-aspect-ratio samples as used here, magnetization reversal occurs by domain wall nucleation and propagation [4, 14]. The $R(H)$ curve \bullet shows first a small reversible decrease of the resistance [15], and then a sharp transition towards the initial resistance at ≈ 55 mT, noted as up^{NoP} . At this field a domain wall propagates through the strip. For the $R(H)$ curve Δ , the resistance also decreases progressively up to dn^P at ≈ 55 mT, but then drops sharply. R is then constant up to up^P at ≈ 65 mT, where a jump towards the initial value is observed. In this case, instead of propagating directly through the sample, the domain wall gets pinned between the voltage probes (probably by some defect arising from the lithographic process), and a higher field is needed to unpin the domain wall [5]. The decrease in resistance ΔR is due to the spin distribution in the domain wall, which gives a negative contribution to the AMR. By comparing ΔR to the total variation of resistance ΔR_{AMR} , we can estimate the width of the domain wall by $W = d\Delta R/\Delta R_{AMR} \approx 250$ nm, with $d=0.5$ μm the distance between the voltage probes. This value is comparable to the width of domain walls observed in Co rings of thickness and width similar to our sample

[16]. We now turn to discussing microwave-assisted switching, measured in

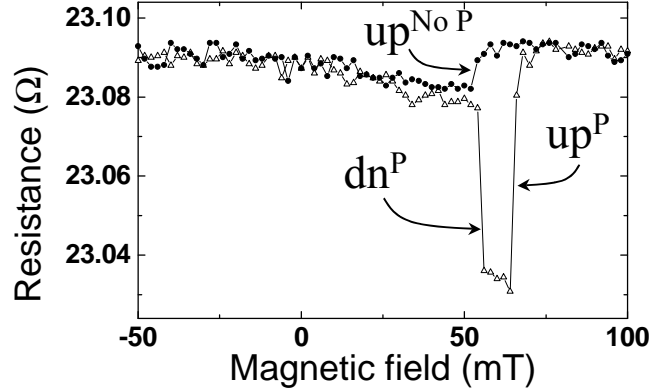


Figure 8.2: Resistance vs. static magnetic field H curves measured at room temperature. Here H is parallel to the strip's longest dimension and slowly swept from -100 mT to $+100$ mT. With the same sample, two behaviors denoted by \bullet or \triangle can be observed.

static field cycles while applying a microwave magnetic field as well. We first set the amplitude of the microwave field to a value of 2.2 mT [17], and study the frequency dependence of the switching fields. Figure 8.3(a) shows results for up^{NoP} and dn^P . The up^{NoP} and dn^P values are distributed over 0.5 mT due to thermal broadening. In order to gain accuracy, the $R(H)$ curve for each frequency was performed 10 times and we plot the averaged values. Within the precision of the measurement up^{NoP} and dn^P are equal: the value of the field at which the domain wall appears between the voltage probes is the same for reversal with and without domain wall pinning. Further, we observe two resonances where the switching fields are decreased at 4.2 and 6.6 GHz. As in FMR measurements, the width and amplitude of these resonances are linked to the Gilbert damping parameter α .

Figure 8.3(b) shows how the switching fields up^{NoP} and dn^P depend on microwave amplitude H_{MW} , recorded for the frequencies 3, 4.2, and 6.6 GHz. The data taken at 3 GHz (outside the resonances in Fig. 8.3(a)) does not depend on H_{MW} . For the data at 4.2 and 6.6 GHz, however, the switching fields up^{NoP} and dn^P decrease linearly with H_{MW} . The precision of our measurement does not allow to discriminate the 4.2 and 6.6 GHz curves. The same procedure is used to analyze the microwave dependence of up^P . Figure 8.3(c) presents results for up^P vs. frequency. Here only one resonance is detected around 4.4 GHz. This behavior is confirmed in Fig. 8.3(d): The switching field up^P stays constant when H_{MW} is increased for both 3 GHz and 6.6 GHz microwave fields. When the frequency of the microwave field is set to 4.2 GHz, up^P decreases with H_{MW} with a step-like dependence. We rule out that the observed phenomena are not FMR related but due to

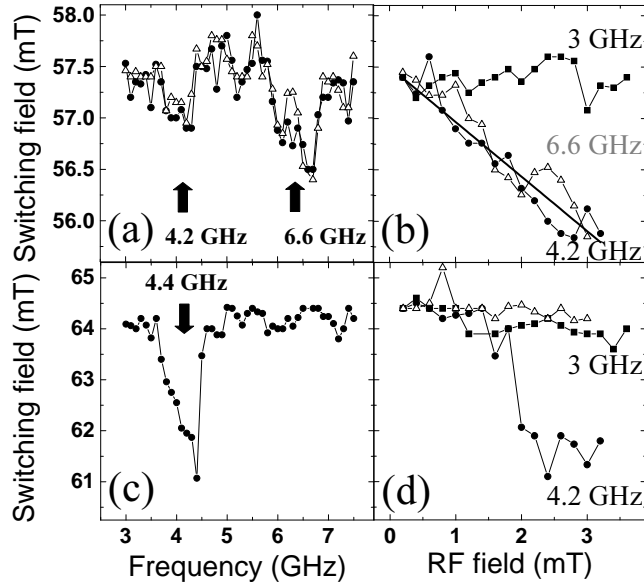


Figure 8.3: (a) Average of up^{NoP} (Δ) and average of dn^P (\bullet) vs. frequency with a 2.2 mT microwave field. (b) Average of up^{NoP} and dn^P vs. H_{MW} at 3 GHz \square , 4.2 GHz \bullet , 6.6 GHz Δ . The line is the fit to the model. (c) \bullet : up^P vs. frequency with a 2.2 mT microwave field (d) up^P vs. H_{MW} at 3 GHz \square , 4.2 GHz \bullet , 6.6 GHz Δ .

resonances in the microwave system. Resistance vs microwave amplitude at high static magnetic field (200 mT), showed heating, but the frequency dependence at fixed amplitude showed variations less than 5 m Ω . With a microwave power of 14 dBm (corresponding to 2.2 mT) such resistance variations of the sample correspond to power variations in the microwave line smaller than 1 dBm, and these cannot explain the large variations in switching fields that we observe (see the reference curves at 3 GHz from Fig. 8.3(b) and (d) where the power is swept up to 18 dBm). We thus conclude that we observe FMR enhanced switching.

The interpretation of the results relies on the knowledge of the magnetic configuration before switching. At static fields slightly below up^P the magnetic configuration is known: it consists of two domains separated by a pinned domain wall between the voltage probes. The magnetic configuration at fields just below to up^{NoP} and dn^P is less clear: the magnetization in the sample can be close to uniform, or a domain wall can already be nucleated, but outside of the voltage probes. Examination of the involved resonance frequency values shows that in our experiments magnetization reversal is always initiated by domain wall dynamics, and not by the dynamics of the uniform mode. According to the Kittel formula, the resonance frequency of

the uniform mode is:

$$f = \gamma_0 / (2\pi) \sqrt{[H + (N_y - N_x)H_D][H + (N_z - N_x)H_D]} \quad (8.1)$$

$N_{x,y,z}$ are the demagnetizing factors and H_D the demagnetizing field. With $N_{x,y} \approx t/w_{x,y}$ (t = thickness, w = width), $N_z = 1 - N_x - N_y$, $H_D = 1.8$ T and $H = -60$ mT, we find $f_{uniform} \approx 21$ GHz. This is far from the measured values, and the observed resonance frequencies also occur well outside the error margin for this estimate. The resonant mode for up^{NoP} and dn^P at 4.2 GHz is then more likely to be a domain wall resonance, just as for the 4.4 GHz resonance in up^P . To confirm this last statement, we solve the following equations for domain wall motion [18]:

$$\frac{\partial \sigma}{\partial x} = \frac{M_s}{\gamma_0} (\dot{\theta} + \alpha W^{-1} \dot{x}) = M_s H - M_s H_C \frac{x}{x_c}, \quad (8.2)$$

$$\begin{aligned} \frac{\partial \sigma}{\partial \theta} &= \frac{M_s}{\gamma_0} (-\dot{x} - \alpha W \dot{\theta}) \\ &= W H_D M_s \sin \theta \cos \theta - W M_s H_{MW} \cos(\omega t). \end{aligned} \quad (8.3)$$

Here σ is the domain wall energy per unit area, M_s the saturation magnetization, γ_0 the gyromagnetic ratio, ω the microwave angular frequency, x represents the domain wall displacement along the strip and θ , the out-of-plane angle of the domain wall, is a deformation parameter. The last term in Eq. 8.3 accounts for a quadratic pinning center of width x_c and strength H_C [19]. For a constant domain wall width W and small displacements, we calculate

$$f = \frac{\gamma_0}{2\pi} \sqrt{\eta H_D H_C}, \quad (8.4)$$

$$H_{SW} = H_C \left[1 - \eta \frac{H_{MW}}{\alpha H_D} \right]. \quad (8.5)$$

Here f is the resonance frequency for the domain wall, with $\eta = W/x_c$. Using the values $H_D = 1.8$ T, $H_C = 57.5$ mT, and $f = 4.2$ GHz, we find with Eq. 8.4 that $\eta = 0.22$. With $W = 250$ nm this gives $x_c \approx 1 \mu\text{m}$ which is a reasonable value since the extension of the potential well can be much larger than the physical dimensions of the pinning center [5]. Eq. 8.5 was obtained by using for the switching condition the depinning of the domain wall at $x > x_c$ and neglecting H_C compared to H_D . This formula allows us to fit the curve at 4.2 GHz of Fig. 8.3(b). Using the value $\eta = 0.22$, the model fits the experimental data very well for $\alpha = 0.013$, close to the 0.01 value measured in polycrystalline cobalt [20]. As a conclusion, both the value of the resonance frequency (4.2 GHz) and the switching field dependence of up^{NoP} and dn^P on H_{MW} at 4.2 GHz confirm that we see single domain wall resonance. We also observed resonances around 4 GHz

in smaller Co samples ($600 \text{ nm} \times 130 \text{ nm} \times 20 \text{ nm}$) where the structure of the domain wall should be similar to the one observed in $2 \mu\text{m} \times 130 \text{ nm} \times 40 \text{ nm}$ strips. When the domain wall is pinned between the voltage probes, the dependence of the switching field up^P is non-linear with respect to the amplitude of the microwave field. This can be explained by strong oscillations in a non-quadratic pinning center. Additionally to the domain wall resonance at 4 GHz, we have observed a resonant mode at 6.6 GHz. This resonance could be attributed to spin-waves or edges mode that can assist the onset of a reversal process.

8.4 Conclusions

We have demonstrated a detection method for FMR in nanomagnets, based on transport measurements and microwave-assisted magnetization reversal. We have used AMR measurements to probe how magnetization reversal of a Co strip is enhanced by resonant microwave magnetic fields. In this high-aspect ratio samples the magnetization reversal occurs by domain wall nucleation and propagation. This reversal mechanism is confirmed by our observations. Contrary to traditional FMR techniques, the presented method allows to study single domain wall dynamics.

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